

**Search Notes**

Application/Control No.

10/762,210

Examiner

TAEYOON KIM

Applicant(s)/Patent under  
Reexamination

BERENSON ET AL.

Art Unit

1651

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
<b>435</b>	<b>372.3</b>	12/28/2008	<b>TK</b>
435	375	12/28/2008	TK
435	325	12/28/2008	TK

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated search	12/29/2008	TK
interference search (udpated)	12/29/2008	TK